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#### **Understanding Embedded - Microprocessors**

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

### **Applications of Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.333GHz
Co-Processors/DSP	Signal Processing; SPE
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/kmpc8548vuauj

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

# 4.3 eTSEC Gigabit Reference Clock Timing

GMII. TBI

The following table provides the eTSEC gigabit reference clocks (EC\_GTX\_CLK125) AC timing specifications for the device.

Parameter/Condition Symbol Min Max Unit **Notes** Typ EC\_GTX\_CLK125 frequency 125 MHz f<sub>G125</sub> EC\_GTX\_CLK125 cycle time 8 ns t<sub>G125</sub> EC\_GTX\_CLK125 rise and fall time 1 ns t<sub>G125R</sub>, t<sub>G125F</sub> 0.75 L/TVDD = 2.5 V1.0 L/TVDD = 3.3 V% EC\_GTX\_CLK125 duty cycle 2, 3 t<sub>G125H</sub>/t<sub>G125</sub>

45

47

55

53

Table 6. EC\_GTX\_CLK125 AC Timing Specifications

#### Notes:

- 1. Rise and fall times for EC\_GTX\_CLK125 are measured from 0.5 and 2.0 V for L/TV<sub>DD</sub> = 2.5 V, and from 0.6 and 2.7 V for L/TV<sub>DD</sub> = 3.3 V.
- 2. Timing is guaranteed by design and characterization.

1000Base-T for RGMII, RTBI

3. EC\_GTX\_CLK125 is used to generate the GTX clock TSEC\_n\_GTX\_CLK for the eTSEC transmitter with 2% degradation. EC\_GTX\_CLK125 duty cycle can be loosened from 47/53% as long as the PHY device can tolerate the duty cycle generated by the TSEC\_n\_GTX\_CLK. See Section 8.2.6, "RGMII and RTBI AC Timing Specifications," for duty cycle for 10Base-T and 100Base-T reference clock.

# 4.4 PCI/PCI-X Reference Clock Timing

When the PCI/PCI-X controller is configured for asynchronous operation, the reference clock for the PCI/PCI-x controller is not the SYSCLK input, but instead the PCIn\_CLK. The following table provides the PCI/PCI-X reference clock AC timing specifications for the device.

Table 7. PCIn\_CLK AC Timing Specifications

At recommended operating conditions (see Table 2) with  $OV_{DD} = 3.3 \text{ V} \pm 165 \text{ mV}$ .

Parameter/Condition	Symbol	Min	Тур	Max	Unit	Notes
PCIn_CLK frequency	f <sub>PCICLK</sub>	16	_	133	MHz	_
PCIn_CLK cycle time	t <sub>PCICLK</sub>	7.5	_	60	ns	_
PCIn_CLK rise and fall time	t <sub>PCIKH</sub> , t <sub>PCIKL</sub>	0.6	1.0	2.1	ns	1, 2
PCIn_CLK duty cycle	t <sub>PCIKHKL</sub> /t <sub>PCICLK</sub>	40	_	60	%	2

#### Notes:

- 1. Rise and fall times for SYSCLK are measured at 0.6 and 2.7 V.
- 2. Timing is guaranteed by design and characterization.

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# 6.2.2 DDR SDRAM Output AC Timing Specifications

### **Table 19. DDR SDRAM Output AC Timing Specifications**

At recommended operating conditions.

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
MCK[n] cycle time, MCK[n]/MCK[n] crossing	t <sub>MCK</sub>	3.75	6	ns	2
ADDR/CMD output setup with respect to MCK 533 MHz 400 MHz 333 MHz	<sup>t</sup> DDKHAS	1.48 1.95 2.40	_ _ _ _	ns	3
ADDR/CMD output hold with respect to MCK 533 MHz 400 MHz 333 MHz	t <sub>DDKHAX</sub>	1.48 1.95 2.40	_ _ _	ns	3
MCS[n] output setup with respect to MCK 533 MHz 400 MHz 333 MHz	<sup>t</sup> DDKHCS	1.48 1.95 2.40	_ _ _	ns	3
MCS[n] output hold with respect to MCK 533 MHz 400 MHz 333 MHz	<sup>t</sup> DDKHCX	1.48 1.95 2.40	_ _ _	ns	3
MCK to MDQS Skew	t <sub>DDKHMH</sub>	-0.6	0.6	ns	4
MDQ/MECC/MDM output setup with respect to MDQS  533 MHz 400 MHz 333 MHz	<sup>t</sup> DDKHDS, <sup>t</sup> DDKLDS	538 700 900	_ _ _ _	ps	5
MDQ/MECC/MDM output hold with respect to MDQS  533 MHz 400 MHz 333 MHz	<sup>t</sup> DDKHDX, <sup>t</sup> DDKLDX	538 700 900	_ _ _ _	ps	5
MDQS preamble start	t <sub>DDKHMP</sub>	$-0.5 \times t_{MCK} - 0.6$	$-0.5 \times t_{MCK} + 0.6$	ns	6

#### 8 Enhanced Three-Speed Ethernet (eTSEC)

This section provides the AC and DC electrical characteristics for the enhanced three-speed Ethernet controller. The electrical characteristics for MDIO and MDC are specified in Section 9, "Ethernet Management Interface Electrical Characteristics."

### 8.1 **Enhanced Three-Speed Ethernet Controller (eTSEC)** (10/100/1Gb Mbps)—GMII/MII/TBI/RGMII/RTBI/RMII Electrical **Characteristics**

The electrical characteristics specified here apply to all gigabit media independent interface (GMII), media independent interface (MII), ten-bit interface (TBI), reduced gigabit media independent interface (RGMII), reduced ten-bit interface (RTBI), and reduced media independent interface (RMII) signals except management data input/output (MDIO) and management data clock (MDC). The RGMII and RTBI interfaces are defined for 2.5 V, while the GMII, MII, and TBI interfaces can be operated at 3.3 or 2.5 V. The GMII, MII, or TBI interface timing is compliant with the IEEE 802.3. The RGMII and RTBI interfaces follow the Reduced Gigabit Media-Independent Interface (RGMII) Specification Version 1.3 (12/10/2000). The RMII interface follows the RMII Consortium RMII Specification Version 1.2 (3/20/1998). The electrical characteristics for MDIO and MDC are specified in Section 9, "Ethernet Management Interface Electrical Characteristics."

#### 8.1.1 eTSEC DC Electrical Characteristics

All GMII, MII, TBI, RGMII, RMII, and RTBI drivers and receivers comply with the DC parametric attributes specified in Table 22 and Table 23. The RGMII and RTBI signals are based on a 2.5-V CMOS interface voltage as defined by JEDEC EIA/JESD8-5.

Parameter	Symbol	Min	Мах	Unit	Notes
Supply voltage 3.3 V	LV <sub>DD</sub> TV <sub>DD</sub>	3.13	3.47	V	1, 2
Output high voltage (LV <sub>DD</sub> /TV <sub>DD</sub> = min, $I_{OH}$ = -4.0 mA)	V <sub>OH</sub>	2.40	$LV_{DD}/TV_{DD} + 0.3$	V	_
Output low voltage (LV <sub>DD</sub> /TV <sub>DD</sub> = min, I <sub>OL</sub> = 4.0 mA)	$V_{OL}$	GND	0.50	V	_
Input high voltage	V <sub>IH</sub>	2.0	$LV_{DD}/TV_{DD} + 0.3$	V	_
Input low voltage	V <sub>IL</sub>	-0.3	0.90	V	_
Input high current (V <sub>IN</sub> = LV <sub>DD</sub> , V <sub>IN</sub> = TV <sub>DD</sub> )	I <sub>IH</sub>	_	40	μΑ	1, 2, 3
Input low current (V <sub>IN</sub> = GND)	I <sub>IL</sub>	-600	_	μΑ	_

Table 22. GMII, MII, RMII, and TBI DC Electrical Characteristics

#### Notes:

- 1. LV<sub>DD</sub> supports eTSECs 1 and 2.
- 2. TV<sub>DD</sub> supports eTSECs 3 and 4.
- 3. The symbol  $V_{IN}$ , in this case, represents the LV<sub>IN</sub> and TV<sub>IN</sub> symbols referenced in Table 1 and Table 2.

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Table 23. GMII, MII, RMII, TBI, RGMII, RTBI, and FIFO DC Electrical Characteristics

Parameters	Symbol	Min	Max	Unit	Notes
Supply voltage 2.5 V	LV <sub>DD</sub> /TV <sub>DD</sub>	2.37	2.63	V	1, 2
Output high voltage (LV <sub>DD</sub> /TV <sub>DD</sub> = Min, $I_{OH} = -1.0 \text{ mA}$ )	V <sub>OH</sub>	2.00	$LV_{DD}/TV_{DD} + 0.3$	V	_
Output low voltage (LV <sub>DD</sub> /TV <sub>DD</sub> = Min, $I_{OL}$ = 1.0 mA)	V <sub>OL</sub>	GND -0.3	0.40	V	_
Input high voltage	V <sub>IH</sub>	1.70	$LV_{DD}/TV_{DD} + 0.3$	V	_
Input low voltage	V <sub>IL</sub>	-0.3	0.90	V	_
Input high current (V <sub>IN</sub> = LV <sub>DD</sub> , V <sub>IN</sub> = TV <sub>DD</sub> )	I <sub>IH</sub>	_	10	μΑ	1, 2, 3
Input low current (V <sub>IN</sub> = GND)	I <sub>IL</sub>	-15	_	μΑ	3

#### Notes:

- 1. LV<sub>DD</sub> supports eTSECs 1 and 2.
- 2. TV<sub>DD</sub> supports eTSECs 3 and 4.
- 3. Note that the symbol V<sub>IN</sub>, in this case, represents the LV<sub>IN</sub> and TV<sub>IN</sub> symbols referenced in Table 1 and Table 2.

# 8.2 FIFO, GMII, MII, TBI, RGMII, RMII, and RTBI AC Timing Specifications

The AC timing specifications for FIFO, GMII, MII, TBI, RGMII, RMII, and RTBI are presented in this section.

### 8.2.1 FIFO AC Specifications

The basis for the AC specifications for the eTSEC's FIFO modes is the double data rate RGMII and RTBI specifications, since they have similar performances and are described in a source-synchronous fashion like FIFO modes. However, the FIFO interface provides deliberate skew between the transmitted data and source clock in GMII fashion.

When the eTSEC is configured for FIFO modes, all clocks are supplied from external sources to the relevant eTSEC interface. That is, the transmit clock must be applied to the eTSECn's TSECn\_TX\_CLK, while the receive clock must be applied to pin TSECn\_RX\_CLK. The eTSEC internally uses the transmit clock to synchronously generate transmit data and outputs an echoed copy of the transmit clock back out onto the TSECn\_GTX\_CLK pin (while transmit data appears on TSECn\_TXD[7:0], for example). It is intended that external receivers capture eTSEC transmit data using the clock on TSECn\_GTX\_CLK as a source- synchronous timing reference. Typically, the clock edge that launched the data can be used, since the clock is delayed by the eTSEC to allow acceptable set-up margin at the receiver. Note that there is relationship between the maximum FIFO speed and the platform speed. For more information see Section 4.5, "Platform to FIFO Restrictions."

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Figure 14 shows the TBI transmit AC timing diagram.

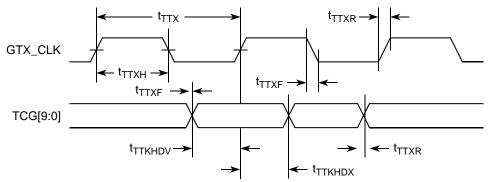


Figure 14. TBI Transmit AC Timing Diagram

### 8.2.4.2 TBI Receive AC Timing Specifications

This table provides the TBI receive AC timing specifications.

**Table 31. TBI Receive AC Timing Specifications** 

Parameter/Condition	Symbol <sup>1</sup>	Min	Тур	Max	Unit
TSECn_RX_CLK[0:1] clock period	t <sub>TRX</sub>	_	16.0	_	ns
TSECn_RX_CLK[0:1] skew	t <sub>SKTRX</sub>	7.5	_	8.5	ns
TSECn_RX_CLK[0:1] duty cycle	t <sub>TRXH</sub> /t <sub>TRX</sub>	40	_	60	%
RCG[9:0] setup time to rising TSECn_RX_CLK	t <sub>TRDVKH</sub>	2.5	_	_	ns
RCG[9:0] hold time to rising TSECn_RX_CLK	t <sub>TRDXKH</sub>	1.5	_	_	ns
TSECn_RX_CLK[0:1] clock rise time (20%–80%)	t <sub>TRXR</sub> <sup>2</sup>	0.7	_	2.4	ns
TSECn_RX_CLK[0:1] clock fall time (80%–20%)	t <sub>TRXF</sub> <sup>2</sup>	0.7	_	2.4	ns

#### Notes:

- 1. The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)</sub> for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>TRDVKH</sub> symbolizes TBI receive timing (TR) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>TRX</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>TRDXKH</sub> symbolizes TBI receive timing (TR) with respect to the time data input signals (D) went invalid (X) relative to the t<sub>TRX</sub> clock reference (K) going to the high (H) state. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t<sub>TRX</sub> represents the TBI (T) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall). For symbols representing skews, the subscript is skew (SK) followed by the clock that is being skewed (TRX).
- 2. Guaranteed by design.

Table 41 describes the timing parameters of the local bus interface at  $BV_{DD} = 2.5 \text{ V}$ .

Table 41. Local Bus Timing Parameters (BV<sub>DD</sub> = 2.5 V)—PLL Enabled

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
Local bus cycle time	t <sub>LBK</sub>	7.5	12	ns	2
Local bus duty cycle	t <sub>LBKH</sub> /t <sub>LBK</sub>	43	57	%	_
LCLK[n] skew to LCLK[m] or LSYNC_OUT	t <sub>LBKSKEW</sub>	_	150	ps	7, 8
Input setup to local bus clock (except LGTA/UPWAIT)	t <sub>LBIVKH1</sub>	1.9	_	ns	3, 4
LGTA/LUPWAIT input setup to local bus clock	t <sub>LBIVKH2</sub>	1.8	_	ns	3, 4
Input hold from local bus clock (except \( \overline{LGTA} \) LUPWAIT)	t <sub>LBIXKH1</sub>	1.1	_	ns	3, 4
LGTA/LUPWAIT input hold from local bus clock	t <sub>LBIXKH2</sub>	1.1	_	ns	3, 4
LALE output transition to LAD/LDP output transition (LATCH hold time)	t <sub>LBOTOT</sub>	1.5	_	ns	6
Local bus clock to output valid (except LAD/LDP and LALE)	t <sub>LBKHOV1</sub>	_	2.1	ns	_
Local bus clock to data valid for LAD/LDP	t <sub>LBKHOV2</sub>	_	2.3	ns	3
Local bus clock to address valid for LAD	t <sub>LBKHOV3</sub>	_	2.4	ns	3
Local bus clock to LALE assertion	t <sub>LBKHOV4</sub>	_	2.4	ns	3
Output hold from local bus clock (except LAD/LDP and LALE)	t <sub>LBKHOX1</sub>	0.8	_	ns	3
Output hold from local bus clock for LAD/LDP	t <sub>LBKHOX2</sub>	0.8	_	ns	3
Local bus clock to output high Impedance (except LAD/LDP and LALE)	t <sub>LBKHOZ1</sub>	_	2.6	ns	5
Local bus clock to output high impedance for LAD/LDP	t <sub>LBKHOZ2</sub>	_	2.6	ns	5

#### Notes:

- 1. The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)</sub>(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)</sub>(reference)(state)(signal)(state) for outputs. For example, t<sub>LBIXKH1</sub> symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the t<sub>LBK</sub> clock reference (K) goes high (H), in this case for clock one (1). Also, t<sub>LBKHOX</sub> symbolizes local bus timing (LB) for the t<sub>LBK</sub> clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
- 2. All timings are in reference to LSYNC IN for PLL enabled and internal local bus clock for PLL bypass mode.
- 3. All signals are measured from  $BV_{DD}/2$  of the rising edge of LSYNC\_IN for PLL enabled or internal local bus clock for PLL bypass mode to  $0.4 \times BV_{DD}$  of the signal in question for 3.3-V signaling levels.
- 4. Input timings are measured at the pin.
- 5. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- 6. t<sub>LBOTOT</sub> is a measurement of the minimum time between the negation of LALE and any change in LAD. t<sub>LBOTOT</sub> is programmed with the LBCR[AHD] parameter.
- 7. Maximum possible clock skew between a clock LCLK[m] and a relative clock LCLK[n]. Skew measured between complementary signals at BV<sub>DD</sub>/2.
- 8. Guaranteed by design.

Figure 22 provides the AC test load for the local bus.

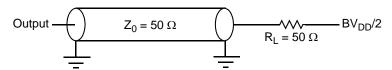


Figure 22. Local Bus AC Test Load

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#### **AC Requirements for SerDes Reference Clocks** 16.2.4

The clock driver selected must provide a high quality reference clock with low phase noise and cycle-to-cycle jitter. Phase noise less than 100 kHz can be tracked by the PLL and data recovery loops and is less of a problem. Phase noise above 15 MHz is filtered by the PLL. The most problematic phase noise occurs in the 1–15 MHz range. The source impedance of the clock driver must be 50  $\Omega$  to match the transmission line and reduce reflections which are a source of noise to the system.

The detailed AC requirements of the SerDes reference clocks are defined by each interface protocol based on application usage. See the following sections for detailed information:

- Section 17.2, "AC Requirements for PCI Express SerDes Clocks"
- Section 18.2, "AC Requirements for Serial RapidIO SD\_REF\_CLK and SD\_REF\_CLK"

#### 16.2.4.1 **Spread Spectrum Clock**

SD REF CLK/SD REF CLK are designed to work with a spread spectrum clock (+0% to -0.5% spreading at 30–33 kHz rate is allowed), assuming both ends have same reference clock. For better results, a source without significant unintended modulation must be used.

#### SerDes Transmitter and Receiver Reference Circuits 16.3

Figure 47 shows the reference circuits for SerDes data lane's transmitter and receiver.

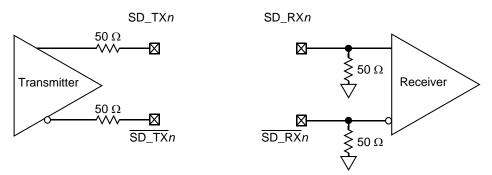


Figure 47. SerDes Transmitter and Receiver Reference Circuits

The DC and AC specification of SerDes data lanes are defined in each interface protocol section below (PCI Express, Serial Rapid IO, or SGMII) in this document based on the application usage:

- Section 17, "PCI Express"
- Section 18, "Serial RapidIO"

Note that external an AC coupling capacitor is required for the above three serial transmission protocols with the capacitor value defined in the specification of each protocol section.

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Symbol	Parameter	Min	Nom	Max	Unit	Comments
L <sub>TX-SKEW</sub>	Total Skew	_	_	20	ns	Skew across all lanes on a Link. This includes variation in the length of SKP ordered set (for example, COM and one to five symbols) at the RX as well as any delay differences arising from the interconnect itself.

#### Notes:

- 1. No test load is necessarily associated with this value.
- 2. Specified at the measurement point and measured over any 250 consecutive UIs. The test load in Figure 50 must be used as the RX device when taking measurements (also see the receiver compliance eye diagram shown in Figure 49). If the clocks to the RX and TX are not derived from the same reference clock, the TX UI recovered from 3500 consecutive UI must be used as a reference for the eye diagram.
- 3. A T<sub>RX-EYE</sub> = 0.40 UI provides for a total sum of 0.60 UI deterministic and random jitter budget for the transmitter and interconnect collected any 250 consecutive UIs. The T<sub>RX-EYE-MEDIAN-to-MAX-JITTER</sub> specification ensures a jitter distribution in which the median and the maximum deviation from the median is less than half of the total. UI jitter budget collected over any 250 consecutive TX UIs. Note that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value. If the clocks to the RX and TX are not derived from the same reference clock, the TX UI recovered from 3500 consecutive UI must be used as the reference for the eye diagram.
- 4. The receiver input impedance shall result in a differential return loss greater than or equal to 15 dB with the D+ line biased to 300 mV and the D- line biased to  $-\{300 \text{ mV} \text{ and a common mode return loss greater than or equal to 6 dB (no bias required) over a frequency range of 50 MHz to 1.25 GHz. This input impedance requirement applies to all valid input levels. The reference impedance for return loss measurements for is 50 <math>\Omega$  to ground for both the D+ and D- line (that is, as measured by a vector network analyzer with 50- $\Omega$  probes—see Figure 50). Note: that the series capacitors CTX is optional for the return loss measurement.
- 5. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM) there is a 5 ms transition time before receiver termination values must be met on all unconfigured lanes of a port.
- 6. The RX DC common mode Impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the RX ground.
- 7. It is recommended that the recovered TX UI is calculated using all edges in the 3500 consecutive UI interval with a fit algorithm using a minimization merit function. Least squares and median deviation fits have worked well with experimental and simulated data.

# 17.5 Receiver Compliance Eye Diagrams

The RX eye diagram in Figure 49 is specified using the passive compliance/test measurement load (see Figure 50) in place of any real PCI Express RX component.

Note: In general, the minimum receiver eye diagram measured with the compliance/test measurement load (see Figure 50) is larger than the minimum receiver eye diagram measured over a range of systems at the input receiver of any real PCI Express component. The degraded eye diagram at the input receiver is due to traces internal to the package as well as silicon parasitic characteristics which cause the real PCI Express component to vary in impedance from the compliance/test measurement load. The input receiver eye diagram is implementation specific and is not specified. RX component designer must provide additional margin to adequately compensate for the degraded minimum receiver eye diagram (shown in Figure 49) expected at the input receiver based on some adequate combination of system simulations and the return loss measured looking into the RX package and silicon. The RX eye diagram must be aligned in time using the jitter median to locate the center of the eye diagram.

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#### **PCI Express**

The eye diagram must be valid for any 250 consecutive UIs.

A recovered TX UI is calculated over 3500 consecutive unit intervals of sample data. The eye diagram is created using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the TX UI.

### NOTE

The reference impedance for return loss measurements is 50. to ground for both the D+ and D- line (that is, as measured by a vector network analyzer with  $50-\Omega$  probes—see Figure 50). Note that the series capacitors, CTX, are optional for the return loss measurement.

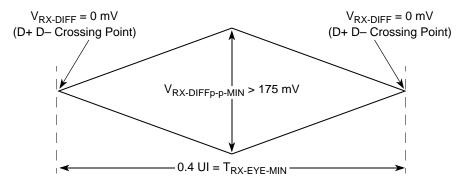


Figure 49. Minimum Receiver Eye Timing and Voltage Compliance Specification

### 17.5.1 Compliance Test and Measurement Load

The AC timing and voltage parameters must be verified at the measurement point, as specified within 0.2 inches of the package pins, into a test/measurement load shown in Figure 50.

#### NOTE

The allowance of the measurement point to be within 0.2 inches of the package pins is meant to acknowledge that package/board routing may benefit from D+ and D- not being exactly matched in length at the package pin boundary.

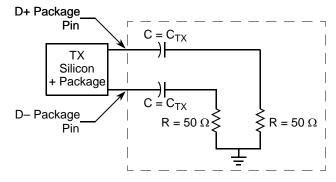


Figure 50. Compliance Test/Measurement Load

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#### Serial RapidIO

transmitter that implements pre-emphasis (to equalize the link and reduce inter-symbol interference) need only comply with the transmitter output compliance mask when pre-emphasis is disabled or minimized.

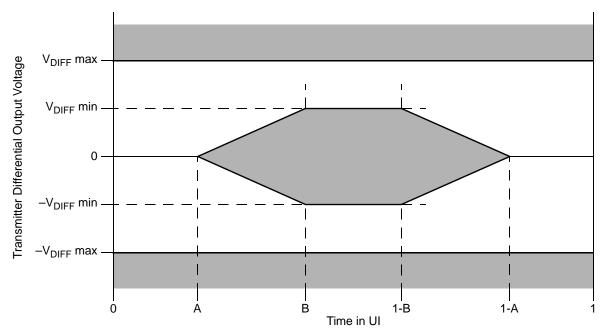


Figure 52. Transmitter Output Compliance Mask

**Table 65. Transmitter Differential Output Eye Diagram Parameters** 

Transmitter Type	V <sub>DIFF</sub> min (mV)	V <sub>DIFF</sub> max (mV)	A (UI)	B (UI)
1.25 GBaud short range	250	500	0.175	0.39
1.25 GBaud long range	400	800	0.175	0.39
2.5 GBaud short range	250	500	0.175	0.39
2.5 GBaud long range	400	800	0.175	0.39
3.125 GBaud short range	250	500	0.175	0.39
3.125 GBaud long range	400	800	0.175	0.39

# 18.7 Receiver Specifications

LP-serial receiver electrical and timing specifications are stated in the text and tables of this section.

Receiver input impedance shall result in a differential return loss better that 10 dB and a common mode return loss better than 6 dB from 100 MHz to  $(0.8) \times$  (baud frequency). This includes contributions from on-chip circuitry, the chip package, and any off-chip components related to the receiver. AC coupling

Table 68. Receiver AC Timing Specifications—3.125 GBaud

Characteristic	Symbol	Range		Unit	Notes
Characteristic	Cymbol	Min	Max		Hotes
Differential input voltage	V <sub>IN</sub>	200	1600	mVp-p	Measured at receiver
Deterministic jitter tolerance	$J_{D}$	0.37	_	UI p-p	Measured at receiver
Combined deterministic and random jitter tolerance	J <sub>DR</sub>	0.55	_	UI p-p	Measured at receiver
Total jitter tolerance <sup>1</sup>	J <sub>T</sub>	0.65	_	UI p-p	Measured at receiver
Multiple input skew	S <sub>MI</sub>	_	22	ns	Skew at the receiver input between lanes of a multilane link
Bit error rate	BER	_	10 <sup>-12</sup>		_
Unit interval	UI	320	320	ps	±100 ppm

### Note:

1. Total jitter is composed of three components, deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 53. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

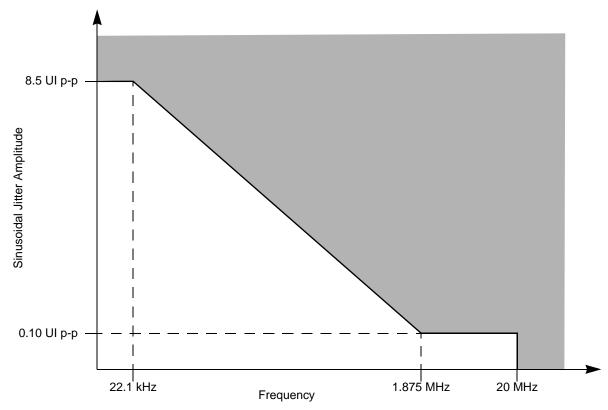


Figure 53. Single Frequency Sinusoidal Jitter Limits

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### **Package Description**

Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
LSYNC_IN	F27	l	BV <sub>DD</sub>	_
LSYNC_OUT	F28	0	BV <sub>DD</sub>	_
	DMA			
DMA_DACK[0:1]	AD3, AE1	0	OV <sub>DD</sub>	5, 9, 102
DMA_DREQ[0:1]	AD4, AE2	I	OV <sub>DD</sub>	_
DMA_DDONE[0:1]	AD2, AD1	0	OV <sub>DD</sub>	_
	Programmable Interrupt Controller			
UDE	AH16	ļ	OV <sub>DD</sub>	_
MCP	AG19	I	OV <sub>DD</sub>	_
IRQ[0:7]	AG23, AF18, AE18, AF20, AG18, AF17, AH24, AE20	I	OV <sub>DD</sub>	_
IRQ[8]	AF19	I	OV <sub>DD</sub>	_
IRQ[9]/DMA_DREQ3	AF21	I	OV <sub>DD</sub>	1
IRQ[10]/DMA_DACK3	AE19	I/O	OV <sub>DD</sub>	1
IRQ[11]/DMA_DDONE3	AD20	I/O	OV <sub>DD</sub>	1
IRQ_OUT	AD18	0	OV <sub>DD</sub>	2, 4
	Ethernet Management Interface			
EC_MDC	AB9	0	OV <sub>DD</sub>	5, 9
EC_MDIO	AC8	I/O	OV <sub>DD</sub>	_
	Gigabit Reference Clock			
EC_GTX_CLK125	V11	I	LV <sub>DD</sub>	_
	Three-Speed Ethernet Controller (Gigabit Etherne	et 1)	•	1
TSEC1_RXD[7:0]	R5, U1, R3, U2, V3, V1, T3, T2	ļ	LV <sub>DD</sub>	_
TSEC1_TXD[7:0]	T10, V7, U10, U5, U4, V6, T5, T8	0	LV <sub>DD</sub>	5, 9
TSEC1_COL	R4	ļ	LV <sub>DD</sub>	_
TSEC1_CRS	V5	I/O	LV <sub>DD</sub>	20
TSEC1_GTX_CLK	U7	0	LV <sub>DD</sub>	_
TSEC1_RX_CLK	U3	ļ	LV <sub>DD</sub>	_
TSEC1_RX_DV	V2	I	LV <sub>DD</sub>	_
TSEC1_RX_ER	T1	I	LV <sub>DD</sub>	_
TSEC1_TX_CLK	Т6	I	LV <sub>DD</sub>	_
TSEC1_TX_EN	U9	0	LV <sub>DD</sub>	30
TSEC1_TX_ER	Т7	0	LV <sub>DD</sub>	_

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Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	Clock			•
RTC	AF16	I	OV <sub>DD</sub>	_
SYSCLK	AH17	I	OV <sub>DD</sub>	<u> </u>
	JTAG			•
TCK	AG28	I	$OV_{DD}$	_
TDI	AH28	Ţ	$OV_{DD}$	12
TDO	AF28	0	OV <sub>DD</sub>	<u> </u>
TMS	AH27	I	$OV_{DD}$	12
TRST	AH23	I	OV <sub>DD</sub>	12
	DFT			•
L1_TSTCLK	AC25	Ţ	$OV_{DD}$	25
L2_TSTCLK	AE22	Ţ	$OV_{DD}$	25
LSSD_MODE	AH20	I	$OV_{DD}$	25
TEST_SEL	AH14	I	$OV_{DD}$	25
	Thermal Management			•
THERM0	AG1	_	_	14
THERM1	AH1	_	_	14
	Power Management			•
ASLEEP	AH18	0	$OV_{DD}$	9, 19, 29
	Power and Ground Signals			-
GND	A11, B7, B24, C1, C3, C5, C12, C15, C26, D8, D11, D16, D20, D22, E1, E5, E9, E12, E15, E17, F4, F26, G12, G15, G18, G21, G24, H2, H6, H8, H28, J4, J12, J15, J17, J27, K7, K9, K11, K27, L3, L5, L12, L16, N11, N13, N15, N17, N19, P4, P9, P12, P14, P16, P18, R11, R13, R15, R17, R19, T4, T12, T14, T16, T18, U8, U11, U13, U15, U17, U19, V4, V12, V18, W6, W19, Y4, Y9, Y11, Y19, AA6, AA14, AA17, AA22, AA23, AB4, AC2, AC11, AC19, AC26, AD5, AD9, AD22, AE3, AE14, AF6, AF10, AF13, AG8, AG27, K28, L24, L26, N24, N27, P25, R28, T24, T26, U24, V25, W28, Y24, Y26, AA24, AA27, AB25, AC28, L21, L23, N22, P20, R23, T21, U22, V20, W23, Y21, U27		_	_
OV <sub>DD</sub>	V16, W11, W14, Y18, AA13, AA21, AB11, AB17, AB24, AC4, AC9, AC21, AD6, AD13, AD17, AD19, AE10, AE8, AE24, AF4, AF12, AF22, AF27, AG26	Power for PCI and other standards (3.3 V)	OV <sub>DD</sub>	_

### Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes	
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- 25. These are test signals for factory use only and must be pulled up (100  $\Omega$ –1 k $\Omega$ ) to OV<sub>DD</sub> for normal machine operation.
- 26.Independent supplies derived from board V<sub>DD</sub>.
- 27.Recommend a pull-up resistor (~1 k $\Omega$ ) be placed on this pin to OV<sub>DD</sub>.
- 29. The following pins must NOT be pulled down during power-on reset: TSEC3\_TXD[3], TSEC4\_TXD3/TSEC3\_TXD7, HRESET\_REQ, TRIG\_OUT/READY/QUIESCE, MSRCID[2:4], ASLEEP.
- 30. This pin requires an external 4.7-k $\Omega$  pull-down resistor to prevent PHY from seeing a valid transmit enable before it is actively driven.
- 31. This pin is only an output in eTSEC3 FIFO mode when used as Rx flow control.
- 32. These pins must be connected to  $XV_{DD}$ .
- 33.TSEC2\_TXD1, TSEC2\_TX\_ER are multiplexed as cfg\_dram\_type[0:1]. They must be valid at power-up, even before HRESET assertion.
- 34. These pins must be pulled to ground through a 300- $\Omega$  (±10%) resistor.
- 35.When a PCI block is disabled, either the POR config pin that selects between internal and external arbiter must be pulled down to select external arbiter if there is any other PCI device connected on the PCI bus, or leave the PCIn\_AD pins as 'no connect' or terminated through 2–10 kΩ pull-up resistors with the default of internal arbiter if the PCIn\_AD pins are not connected to any other PCI device. The PCI block drives the PCIn\_AD pins if it is configured to be the PCI arbiter—through POR config pins—irrespective of whether it is disabled via the DEVDISR register or not. It may cause contention if there is any other PCI device connected on the bus.
- 36.MDIC0 is grounded through an 18.2- $\Omega$  precision 1% resistor and MDIC1 is connected to GV<sub>DD</sub> through an 18.2- $\Omega$  precision 1% resistor. These pins are used for automatic calibration of the DDR IOs.
- 38. These pins must be left floating.
- 39. If PCI1 or PCI2 is configured as PCI asynchronous mode, a valid clock must be provided on pin PCI1\_CLK or PCI2\_CLK. Otherwise the processor will not boot up.
- 40. These pins must be connected to GND.
- 101. This pin requires an external 4.7-k $\Omega$  resistor to GND.
- 102.For Rev. 2.x silicon, DMA\_DACK[0:1] must be 0b11 during POR configuration; for rev. 1.x silicon, the pin values during POR configuration are don't care.
- 103.If these pins are not used as GPINn (general-purpose input), they must be pulled low (to GND) or high (to  $LV_{DD}$ ) through 2–10 k $\Omega$  resistors.
- 104. These must be pulled low to GND through 2–10 k $\Omega$  resistors if they are not used.
- 105. These must be pulled low or high to  $LV_{DD}$  through 2–10 k $\Omega$  resistors if they are not used.
- 106. For rev. 2.x silicon, DMA\_DACK[0:1] must be 0b10 during POR configuration; for rev. 1.x silicon, the pin values during POR configuration are don't care.
- 107.For rev. 2.x silicon, DMA\_DACK[0:1] must be 0b01 during POR configuration; for rev. 1.x silicon, the pin values during POR configuration are don't care.
- 108.For rev. 2.x silicon, DMA\_DACK[0:1] must be 0b11 during POR configuration; for rev. 1.x silicon, the pin values during POR configuration are don't care.
- 109. This is a test signal for factory use only and must be pulled down (100  $\Omega$  1 k $\Omega$ ) to GND for normal machine operation.
- 110. These pins must be pulled high to  $OV_{DD}$  through 2–10 k $\Omega$  resistors.
- 111.If these pins are not used as GPINn (general-purpose input), they must be pulled low (to GND) or high (to OV<sub>DD</sub>) through 2–10 k $\Omega$  resistors.
- 112. This pin must not be pulled down during POR configuration.
- 113.These should be pulled low or high to  ${\rm OV_{DD}}$  through 2–10 k $\Omega$  resistors.

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Table 74. MPC8543E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
SENSEVSS	M16	_	_	13
	Analog Signals			
MVREF	A18	I Reference voltage signal for DDR	MVREF	_
SD_IMP_CAL_RX	L28	I	200 Ω (±1%) to GND	_
SD_IMP_CAL_TX	AB26	I	100 Ω (±1%) to GND	_
SD_PLL_TPA	U26	0	AVDD_SRDS	24

**Note:** All note references in this table use the same numbers as those for Table 71. See Table 71 for the meanings of these notes.

Table 77. Processor Core Clocking Specifications (MPC8543E)

	Maximum Processor Core Frequency					
Characteristic	800	MHz 1000		MHz	Unit	Notes
	Min	Max	Min	Max		
e500 core processor frequency	800	800	800	1000	MHz	1, 2

#### Notes:

- Caution: The CCB to SYSCLK ratio and e500 core to CCB ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB frequency do not exceed their respective maximum or minimum operating frequencies. See Section 20.2, "CCB/SYSCLK PLL Ratio," and Section 20.3, "e500 Core PLL Ratio," for ratio settings.
- 2.) The minimum e500 core frequency is based on the minimum platform frequency of 333 MHz.

Table 78. Memory Bus Clocking Specifications (MPC8548E and MPC8547E)

	Maximum Process			
Characteristic	1000, 1200, 1333 MHz			Notes
	Min	Max		
Memory bus clock speed	166	266	MHz	1, 2

#### Notes:

- Caution: The CCB clock to SYSCLK ratio and e500 core to CCB clock ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB clock frequency do not exceed their respective maximum or minimum operating frequencies. See Section 20.2, "CCB/SYSCLK PLL Ratio," and Section 20.3, "e500 Core PLL Ratio," for ratio settings.
- 2. The memory bus speed is half of the DDR/DDR2 data rate, hence, half of the platform clock frequency.

Table 79. Memory Bus Clocking Specifications (MPC8545E)

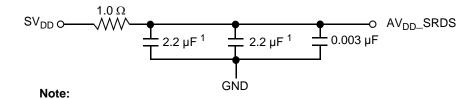
Characteristic	Maximum Process 800, 1000,	Unit	Notes	
	Min	Max	-	
Memory bus clock speed	166	200	MHz	1, 2

#### Notes:

- Caution: The CCB clock to SYSCLK ratio and e500 core to CCB clock ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB clock frequency do not exceed their respective maximum or minimum operating frequencies. See Section 20.2, "CCB/SYSCLK PLL Ratio," and Section 20.3, "e500 Core PLL Ratio," for ratio settings.
- 2. The memory bus speed is half of the DDR/DDR2 data rate, hence, half of the platform clock frequency.

MPC8548E PowerQUICC III Integrated Processor Hardware Specifications, Rev. 9

the ground plane. Use ceramic chip capacitors with the highest possible self-resonant frequency. All traces must be kept short, wide and direct.



1. An 0805 sized capacitor is recommended for system initial bring-up.

Figure 60. SerDes PLL Power Supply Filter

Note the following:

- AV<sub>DD</sub>\_SRDS must be a filtered version of SV<sub>DD</sub>.
- Signals on the SerDes interface are fed from the  $XV_{DD}$  power plane.

#### 22.3 **Decoupling Recommendations**

Due to large address and data buses, and high operating frequencies, the device can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the device system, and the device itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each V<sub>DD</sub>, TV<sub>DD</sub>, BV<sub>DD</sub>, OV<sub>DD</sub>, GV<sub>DD</sub>, and LV<sub>DD</sub> pin of the device. These decoupling capacitors must receive their power from separate V<sub>DD</sub>, TV<sub>DD</sub>, BV<sub>DD</sub>, OV<sub>DD</sub>, GV<sub>DD</sub>, LV<sub>DD</sub>, and GND power planes in the PCB, utilizing short low impedance traces to minimize inductance. Capacitors must be placed directly under the device using a standard escape pattern as much as possible. If some caps are to be placed surrounding the part it must be routed with large trace to minimize the inductance.

These capacitors must have a value of 0.1 µF. Only ceramic SMT (surface mount technology) capacitors must be used to minimize lead inductance, preferably 0402 or 0603 sizes. Besides, it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the V<sub>DD</sub>, TV<sub>DD</sub>, BV<sub>DD</sub>, OV<sub>DD</sub>, GV<sub>DD</sub>, and LV<sub>DD</sub>, planes, to enable quick recharging of the smaller chip capacitors. These bulk capacitors must have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They must also be connected to the power and ground planes through two vias to minimize inductance. Suggested bulk capacitors—100–330 µF (AVX TPS tantalum or Sanyo OSCON). However, customers must work directly with their power regulator vendor for best values, types and quantity of bulk capacitors.

#### SerDes Block Power Supply Decoupling Recommendations 22.4

The SerDes block requires a clean, tightly regulated source of power ( $SV_{DD}$  and  $XV_{DD}$ ) to ensure low jitter on transmit and reliable recovery of data in the receiver. An appropriate decoupling scheme is outlined below.

Only surface mount technology (SMT) capacitors must be used to minimize inductance. Connections from all capacitors to power and ground must be done with multiple vias to further reduce inductance.

MPC8548E PowerQUICC III Integrated Processor Hardware Specifications, Rev. 9 Freescale Semiconductor 137 as shown in Figure 63. If this is not possible, the isolation resistor allows future access to  $\overline{TRST}$  in case a JTAG interface may need to be wired onto the system in future debug situations.

• No pull-up/pull-down is required for TDI, TMS, TDO, or TCK.

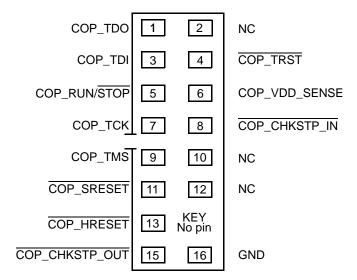


Figure 62. COP Connector Physical Pinout

#### **System Design Information**

• SD\_REF\_CLK

#### NOTE

It is recommended to power down the unused lane through SRDSCR1[0:7] register (offset = 0xE\_0F08) (this prevents the oscillations and holds the receiver output in a fixed state) that maps to SERDES lane 0 to lane 7 accordingly.

Pins V28 and M26 must be tied to  $XV_{DD}$ . Pins V27 and M25 must be tied to GND through a 300- $\Omega$  resistor.

### 22.11 Guideline for PCI Interface Termination

PCI termination if PCI 1 or PCI 2 is not used at all.

Option 1

If PCI arbiter is enabled during POR:

- All AD pins are driven to the stable states after POR. Therefore, all ADs pins can be floating.
- All PCI control pins can be grouped together and tied to  $OV_{DD}$  through a single 10-k $\Omega$  resistor.
- It is optional to disable PCI block through DEVDISR register after POR reset.

Option 2

If PCI arbiter is disabled during POR:

- All AD pins are in the input state. Therefore, all ADs pins need to be grouped together and tied to OV<sub>DD</sub> through a single (or multiple) 10-kΩ resistor(s).
- All PCI control pins can be grouped together and tied to  $OV_{DD}$  through a single 10-k $\Omega$  resistor.
- It is optional to disable PCI block through DEVDISR register after POR reset.

### 22.12 Guideline for LBIU Termination

If the LBIU parity pins are not used, the following is the termination recommendation:

- For LDP[0:3]—tie them to ground or the power supply rail via a 4.7-k $\Omega$  resistor.
- For LPBSE—tie it to the power supply rail via a 4.7-k $\Omega$  resistor (pull-up resistor).

# 23 Ordering Information

Ordering information for the parts fully covered by this specification document is provided in Section 23.1, "Part Numbers Fully Addressed by this Document."

## 23.1 Part Numbers Fully Addressed by this Document

This table provides the Freescale part numbering nomenclature for the device. Note that the individual part numbers correspond to a maximum processor core frequency. For available frequencies, contact your local Freescale sales office. In addition to the processor frequency, the part-numbering scheme also includes an application modifier that may specify special application conditions. Each part number also contains a revision code that refers to the die mask revision number.

Table 87. Part Numbering Nomenclature

MPC	nnnnn	t	рр	ff	С	r
Product Code	Part Identifier	Temperature	Package <sup>1, 2, 3</sup>	Processor Frequency <sup>4</sup>	Core Frequency	Silicon Version
MPC	8548E	Blank = 0 to 105°C C = -40° to 105°C	HX = CBGA VU = Pb-free CBGA PX = PBGA VT = Pb-free PBGA	AV = 1500 <sup>3</sup> AU = 1333 AT = 1200 AQ = 1000	J = 533 H = 500 <sup>5</sup> G = 400	Blank = Ver. 2.0 (SVR = 0x80390020) A = Ver. 2.1.1 B = Ver. 2.1.2 C = Ver. 2.1.3 (SVR = 0x80390021) D = Ver. 3.1.x (SVR = 0x80390031)
	8548					Blank = Ver. 2.0 (SVR = 0x80310020) A = Ver. 2.1.1 B = Ver. 2.1.2 C = Ver. 2.1.3 (SVR = 0x80310021) D = Ver. 3.1.x (SVR = 0x80310031)
	8547E			AU = 1333 AT = 1200 AQ = 1000	J = 533 G = 400	Blank = Ver. 2.0 (SVR = 0x80390120) A = Ver. 2.1.1 B = Ver. 2.1.2 C = Ver. 2.1.3 (SVR = 0x80390121) D = Ver. 3.1.x (SVR = 0x80390131)
	8547					Blank = Ver. 2.0 (SVR = 0x80390120) A = Ver. 2.1.1 B = Ver. 2.1.2 C = Ver. 2.1.3 (SVR = 0x80310121) D = Ver. 3.1.x (SVR = 0x80310131)